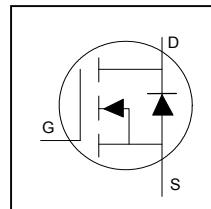


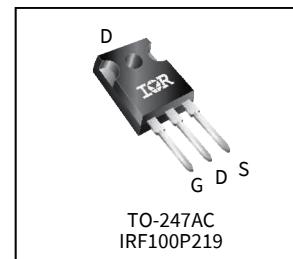
IR MOSFET - StrongIRFET™

Applications

- UPS and Inverter applications
- Half-bridge and full-bridge topologies
- Resonant mode power supplies
- DC/DC and AC/DC converters
- OR-ing and redundant power switches
- Brushed and BLDC Motor drive applications
- Battery powered circuits



V_{DSS}	100V
$R_{DS(on)}$ typ.	1.4mΩ
max	1.7mΩ
I_D (Silicon Limited)	304A①
I_D (Package Limited)	195A



Benefits

- Improved Gate, Avalanche and Dynamic dv/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dv/dt and di/dt Capability
- Pb-Free ; RoHS Compliant ; Halogen-Free



Halogen-Free



RoHS

Base part number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
IRF100P219	TO-247AC	Tube	25	IRF100P219

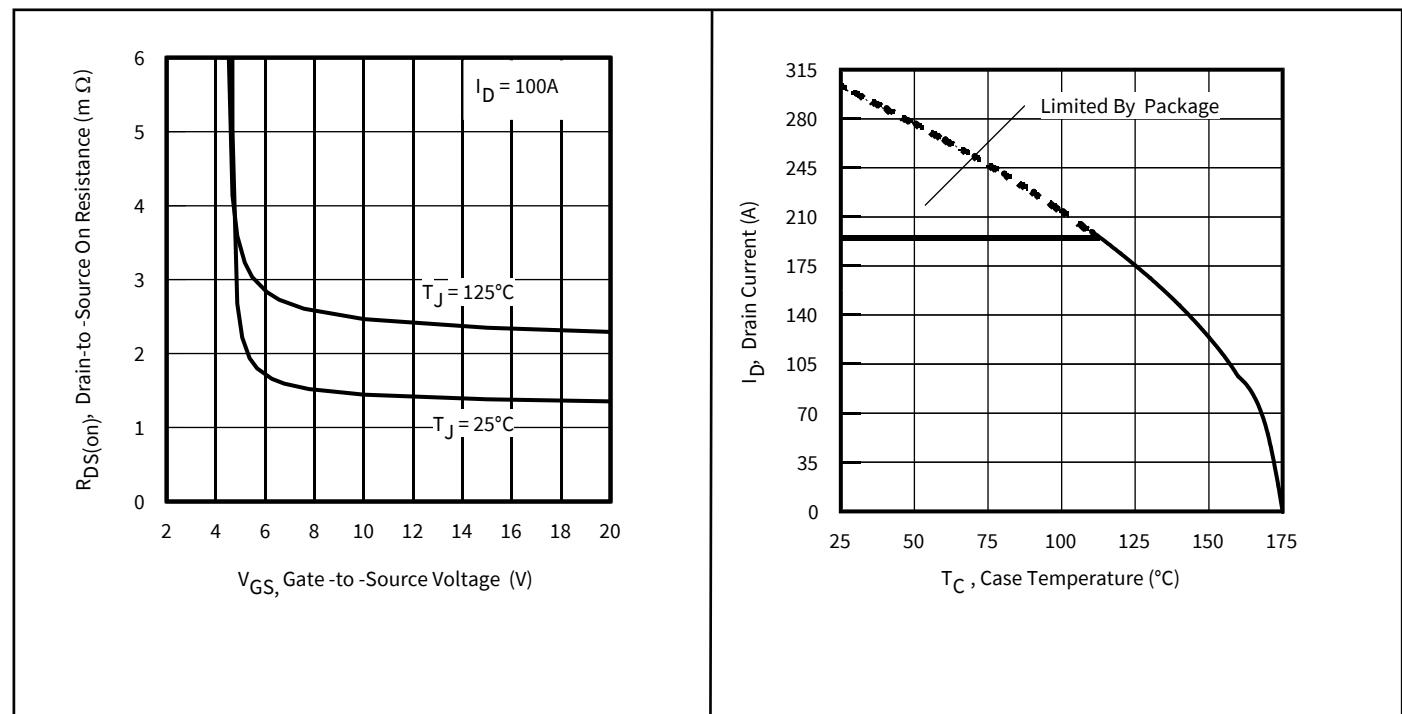


Figure 1 Typical On-Resistance vs. Gate Voltage

Figure 2 Maximum Drain Current vs. Case Temperature

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1 Parameters

Table1 Key performance parameters

Parameter	Values	Units
V _{DS}	100	V
R _{DS(on)} max	1.7	mΩ
I _D (Silicon Limited)	304 ⓘ	A
I _D (Package Limited)	195	A

2 Maximum ratings and thermal characteristics

Table 2 Maximum ratings (at $T_J=25^\circ\text{C}$, unless otherwise specified)

Parameter	Symbol	Conditions	Values	Unit
Continuous Drain Current (Silicon Limited)	I_D	$T_C = 25^\circ\text{C}$, $V_{GS} @ 10\text{V}$	304 ①	A
Continuous Drain Current (Silicon Limited)	I_D	$T_C = 100^\circ\text{C}$, $V_{GS} @ 10\text{V}$	215 ①	
Continuous Drain Current (Package Limited)	I_D	$T_C = 25^\circ\text{C}$, $V_{GS} @ 10\text{V}$	195	
Pulsed Drain Current ②	I_{DM}	$T_C = 25^\circ\text{C}$	780 ⑨	
Maximum Power Dissipation	P_D	$T_C = 25^\circ\text{C}$	341	
Linear Derating Factor		$T_C = 25^\circ\text{C}$	2.3	
Gate-to-Source Voltage	V_{GS}	-	± 20	V
Operating Junction and Storage Temperature Range	T_J T_{STG}	-	-55 to +175	°C
Soldering Temperature, for 10 seconds (1.6mm from case)	-	-	300	
Mounting Torque, 6-32 or M3 Screw	-	-	10 lbf·in (1.1 N·m)	

Table 3 Thermal characteristics

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Junction-to-Case ⑧	$R_{\theta JC}$	T_J approximately 90°C	-	-	0.44	°C/W
Case-to-Sink, Flat Greased Surface	$R_{\theta CS}$	-	-	0.24	-	
Junction-to-Ambient	$R_{\theta JA}$	-	-	-	40	

Table 4 Avalanche characteristics

Parameter	Symbol	Values	Unit
Single Pulse Avalanche Energy ③	E_{AS} (Thermally limited)	464	mJ
Avalanche Current ②	I_{AR}	See Fig 16, 17, 23a, 23b	A
Repetitive Avalanche Energy ②	E_{AR}		mJ

Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 195A. Note that Current limitations arising from heating of the device leads may occur with some lead mounting arrangements. (Refer to AN-1140)
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ Limited by T_{Jmax} , starting $T_J = 25^\circ\text{C}$, $L = 0.093\text{mH}$, $R_G = 50\Omega$, $I_{AS} = 100\text{A}$, $V_{GS} = 10\text{V}$.
- ④ $I_{SD} \leq 100\text{A}$, $dI/dt \leq 1950\text{A}/\mu\text{s}$, $V_{DD} \leq V_{(BR)DSS}$, $T_J \leq 175^\circ\text{C}$.
- ⑤ Pulse width $\leq 400\mu\text{s}$; duty cycle $\leq 2\%$.
- ⑥ C_{oss} eff. (TR) is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .
- ⑦ C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .
- ⑧ R_θ is measured at T_J approximately 90°C .
- ⑨ Pulse drain current is limited to 780A by source bonding technology.

3 Electrical characteristics

Table 5 Static characteristics

Parameter	Symbol	Conditions	Values			Unit
			Min.	Typ.	Max.	
Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 1.0mA$	100	-	-	V
Breakdown Voltage Temp. Coefficient	$\Delta V_{(BR)DSS}/\Delta T_J$	Reference to 25°C, $I_D = 2.0mA$ ②	-	0.04	-	V/°C
Static Drain-to-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 100A$	-	1.4	1.7	mΩ
		$V_{GS} = 6V, I_D = 50A$	-	1.7	2.1	
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 278\mu A$	2.2	-	3.8	V
Drain-to-Source Leakage Current	I_{DSS}	$V_{DS} = 100V, V_{GS} = 0V$	-	-	5.0	μA
		$V_{DS} = 100V, V_{GS} = 0V, T_J = 125°C$	-	-	100	
Gate-to-Source Forward Leakage	I_{GSS}	$V_{GS} = 20V$	-	-	100	nA
Gate Resistance	R_G		-	1.2	-	Ω

Table 6 Dynamic characteristics

Parameter	Symbol	Conditions	Values			Unit
			Min.	Typ.	Max.	
Forward Trans conductance	g_{fs}	$V_{DS} = 25V, I_D = 100A$	224	-	-	S
Total Gate Charge	Q_g	$I_D = 100A$ $V_{DS} = 50V$ $V_{GS} = 10V$	-	180	270	nC
Gate-to-Source Charge	Q_{gs}		-	50	-	
Gate-to-Drain Charge	Q_{gd}		-	40	-	
Total Gate Charge Sync. ($Q_g - Q_{gd}$)	Q_{sync}		-	140	-	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 50V$ $I_D = 100A$ $R_G = 2.7\Omega$ $V_{GS} = 10V$	-	30	-	ns
Rise Time	t_r		-	90	-	
Turn-Off Delay Time	$t_{d(off)}$		-	100	-	
Fall Time	t_f		-	80	-	
Input Capacitance	C_{iss}	$V_{GS} = 0V$ $V_{DS} = 50V$ $f = 1.0MHz, \text{ See Fig.7}$	-	12020	-	pF
Output Capacitance	C_{oss}		-	1950	-	
Reverse Transfer Capacitance	C_{rss}		-	50	-	
Effective Output Capacitance (Energy Related)	$C_{oss\ eff.\ (ER)}$	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V$ ⑦	-	2380	-	
Output Capacitance (Time Related)	$C_{oss\ eff.\ (TR)}$	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V$ ⑥	-	2760	-	

Table 7 Reverse Diode

Parameter	Symbol	Conditions	Values			Unit
			Min.	Typ.	Max.	
Continuous Source Current (Body Diode)	I_s	MOSFET symbol showing the integral reverse p-n junction diode.	-	-	304①	A
Pulsed Source Current (Body Diode) ②	I_{SM}		-	-	780⑨	
Diode Forward Voltage	V_{SD}	$T_J = 25^\circ C, I_s = 100A, V_{GS} = 0V$ ⑤	-	-	1.2	V
Peak Diode Recovery dv/dt ④	dv/dt	$T_J = 175^\circ C, I_s = 100A, V_{DS} = 100V$	-	2.5	-	V/ns
Reverse Recovery Time	t_{rr}	$T_J = 25^\circ C$ $T_J = 125^\circ C$	$V_{DD} = 85V$ $I_F = 100A,$ $di/dt = 100A/\mu s$ ④	- -	90 100	-
Reverse Recovery Charge	Q_{rr}	$T_J = 25^\circ C$ $T_J = 125^\circ C$	$di/dt = 100A/\mu s$ ④	- -	224 280	-
Reverse Recovery Current	I_{RRM}	$T_J = 25^\circ C$	-	4.3	-	A

4 Electrical characteristic diagrams

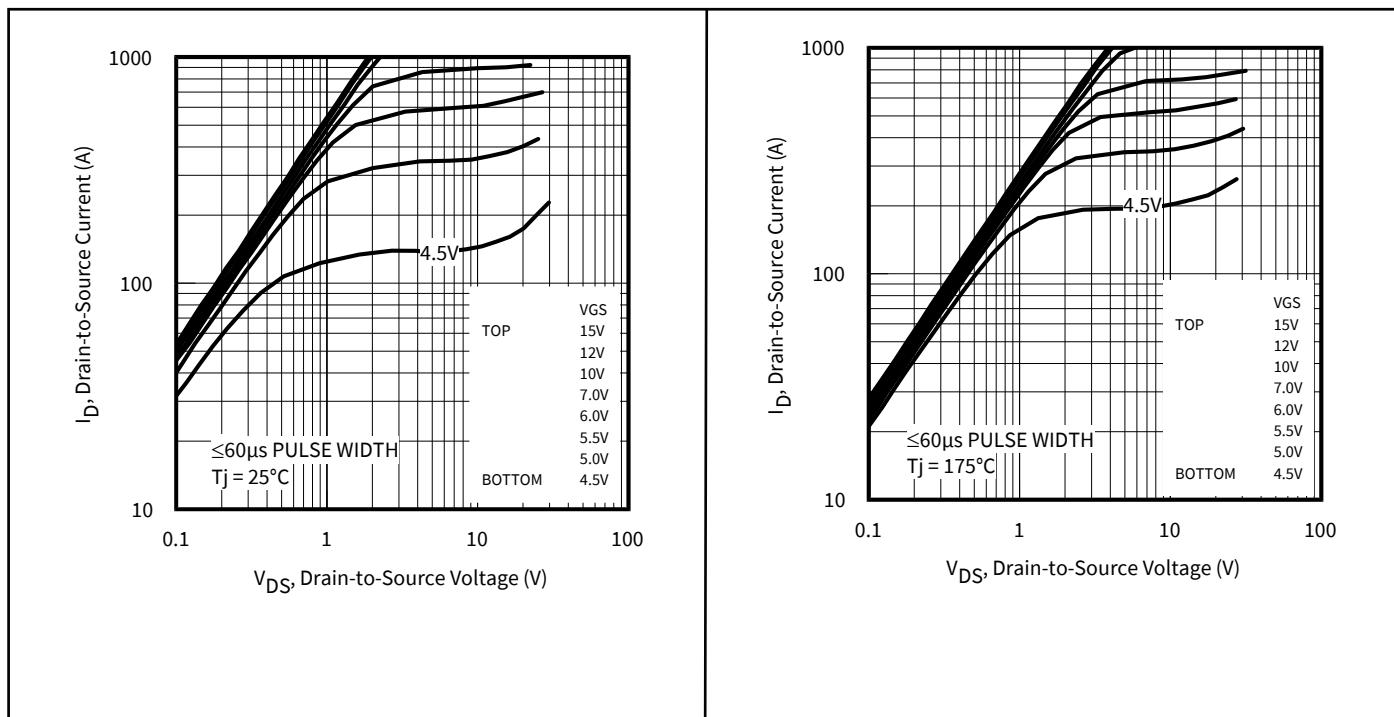


Figure 3 Typical Output Characteristics

Figure 4 Typical Output Characteristics

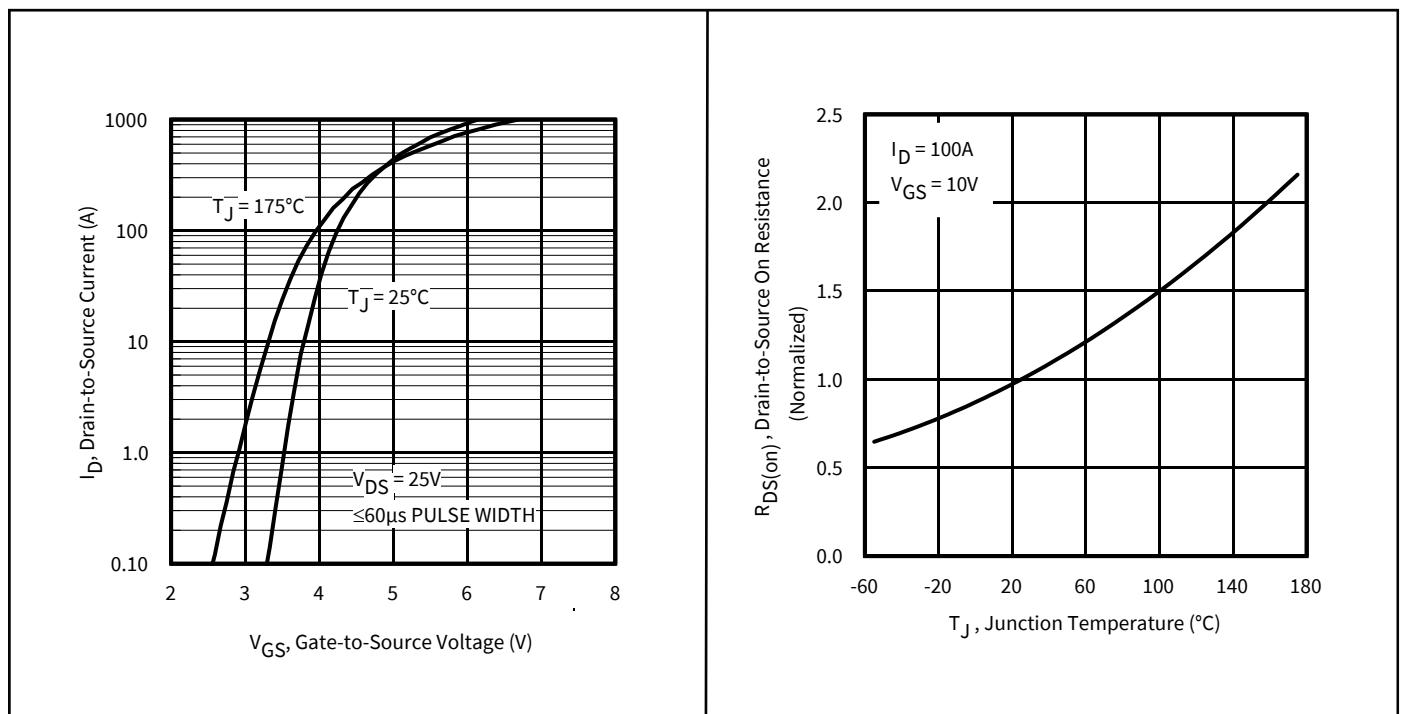


Figure 5 Typical Transfer Characteristics

Figure 6 Normalized On-Resistance vs. Temperature

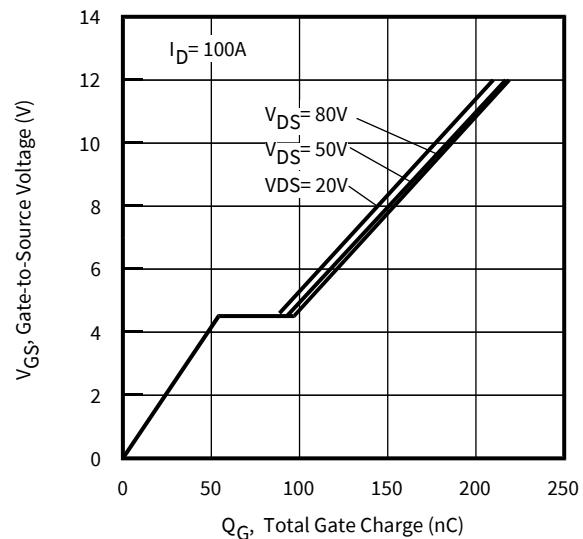
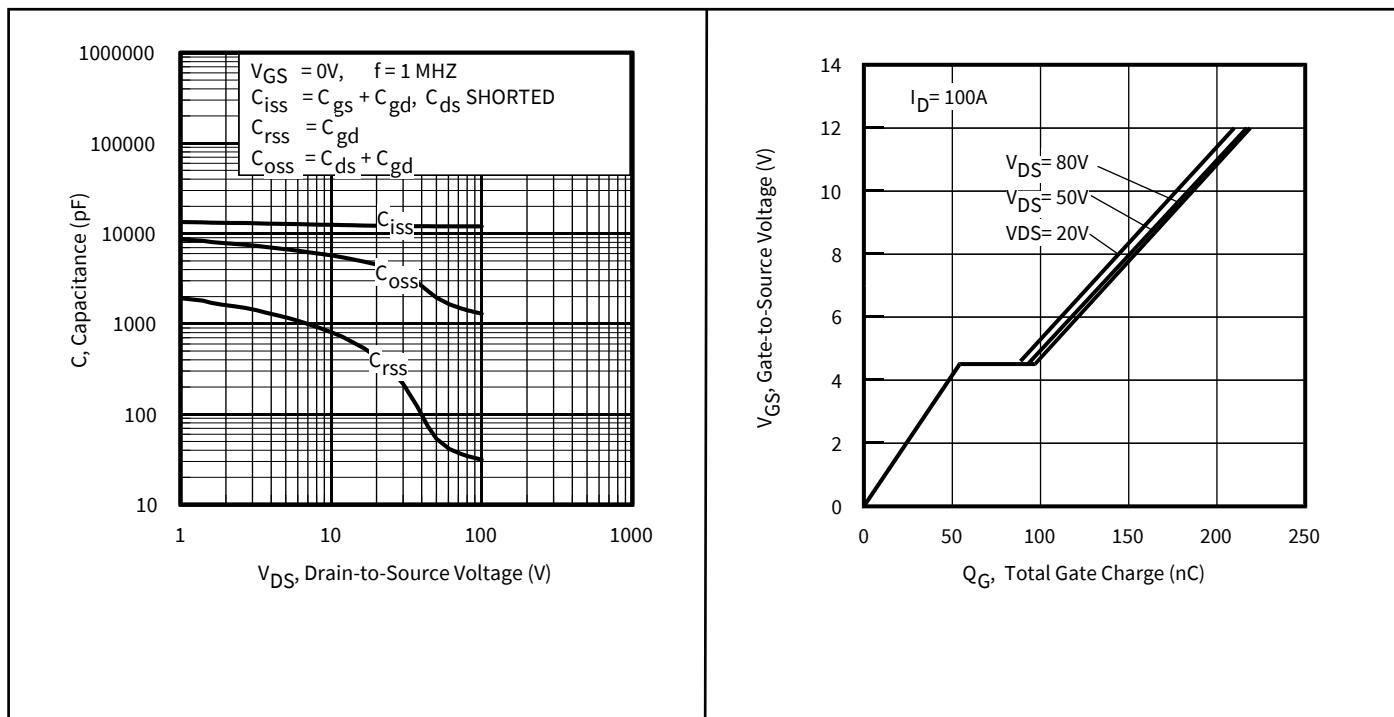
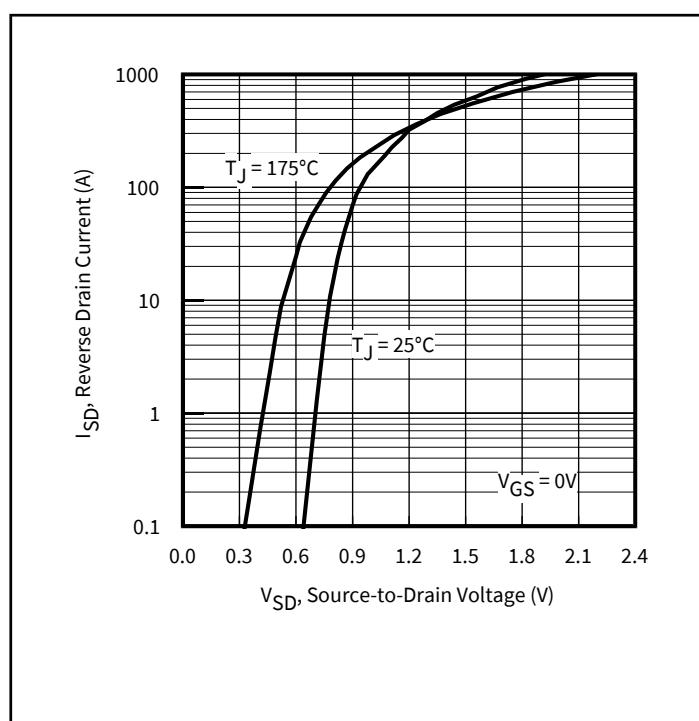


Figure 7 Typical Capacitance vs. Drain-to-Source Voltage

Figure 8 Typical Gate Charge vs. Gate-to-Source Voltage



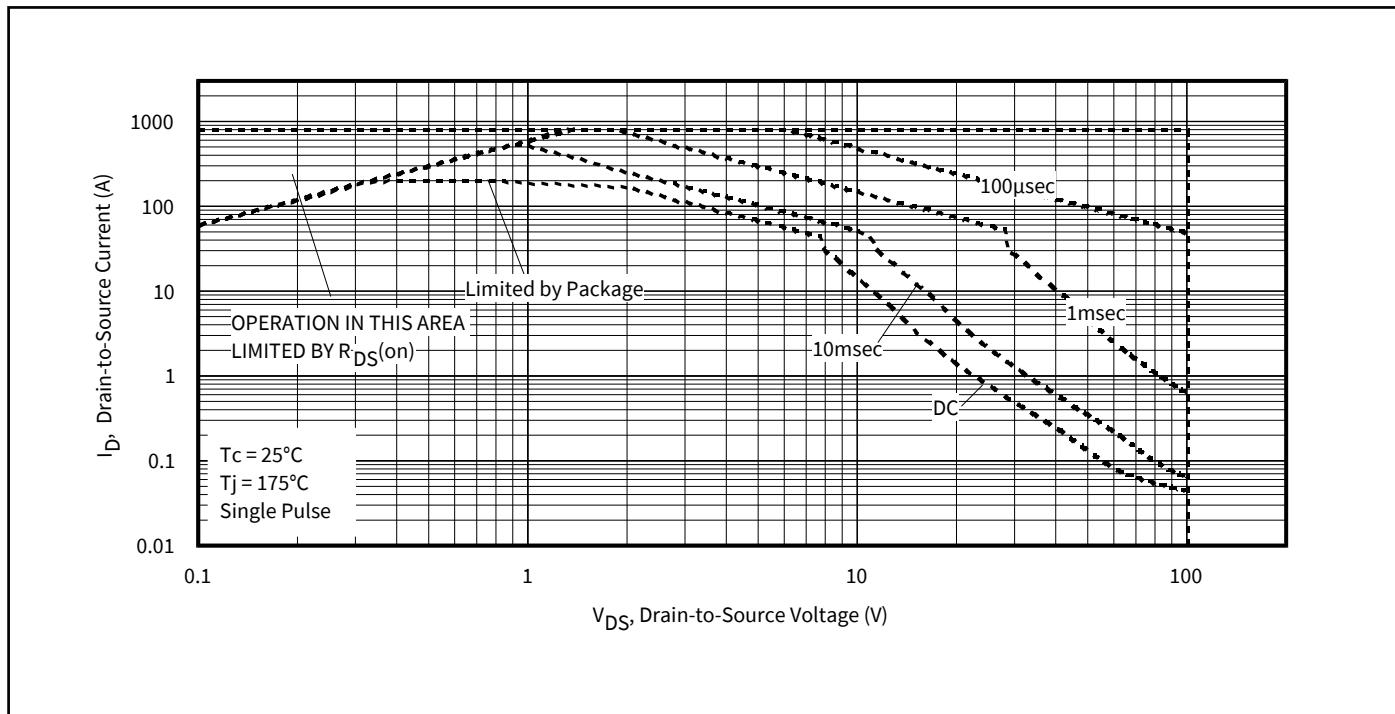


Figure 10 Maximum Safe Operating Area

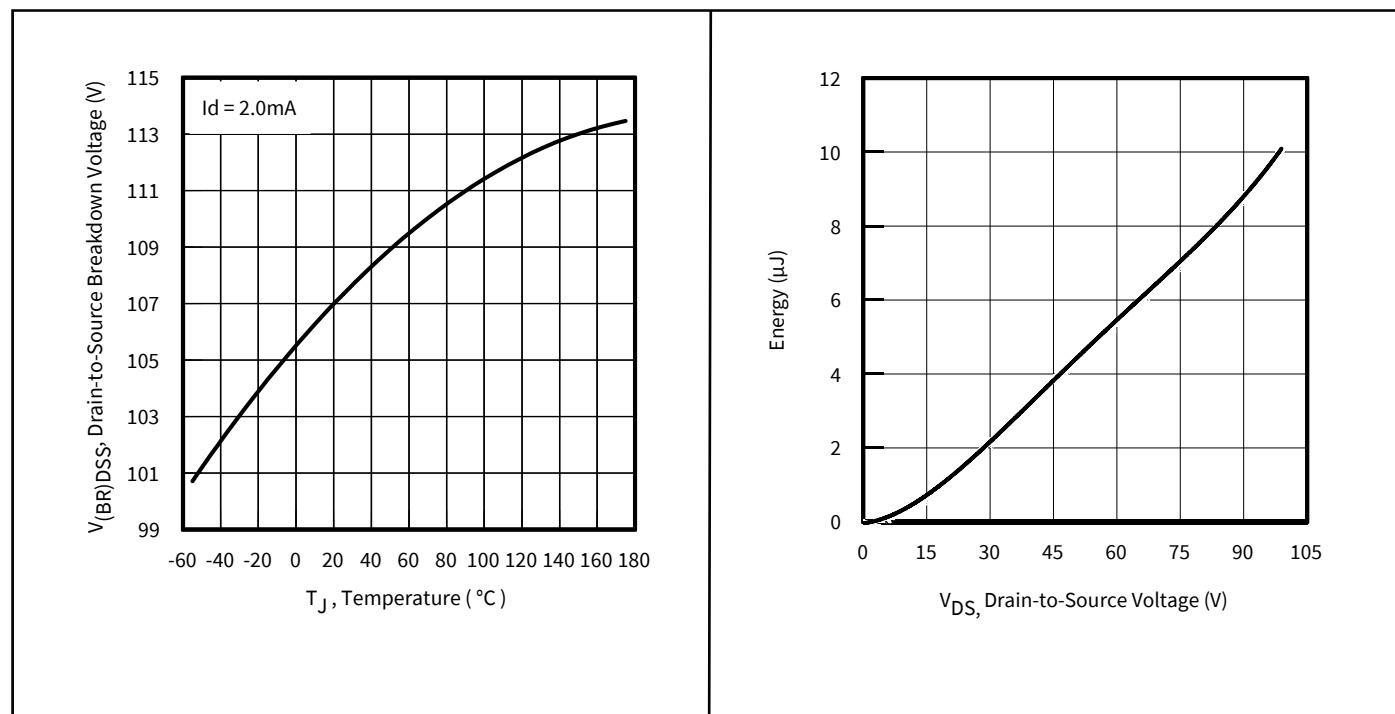
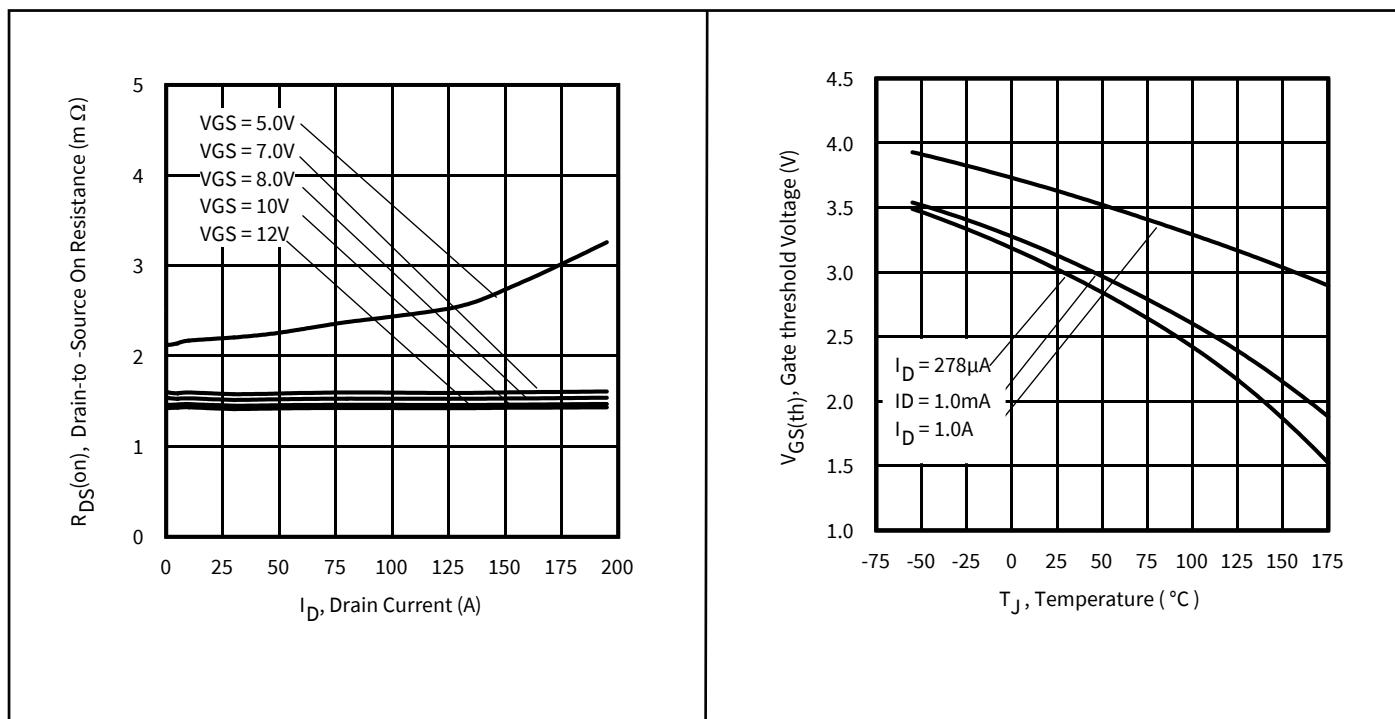
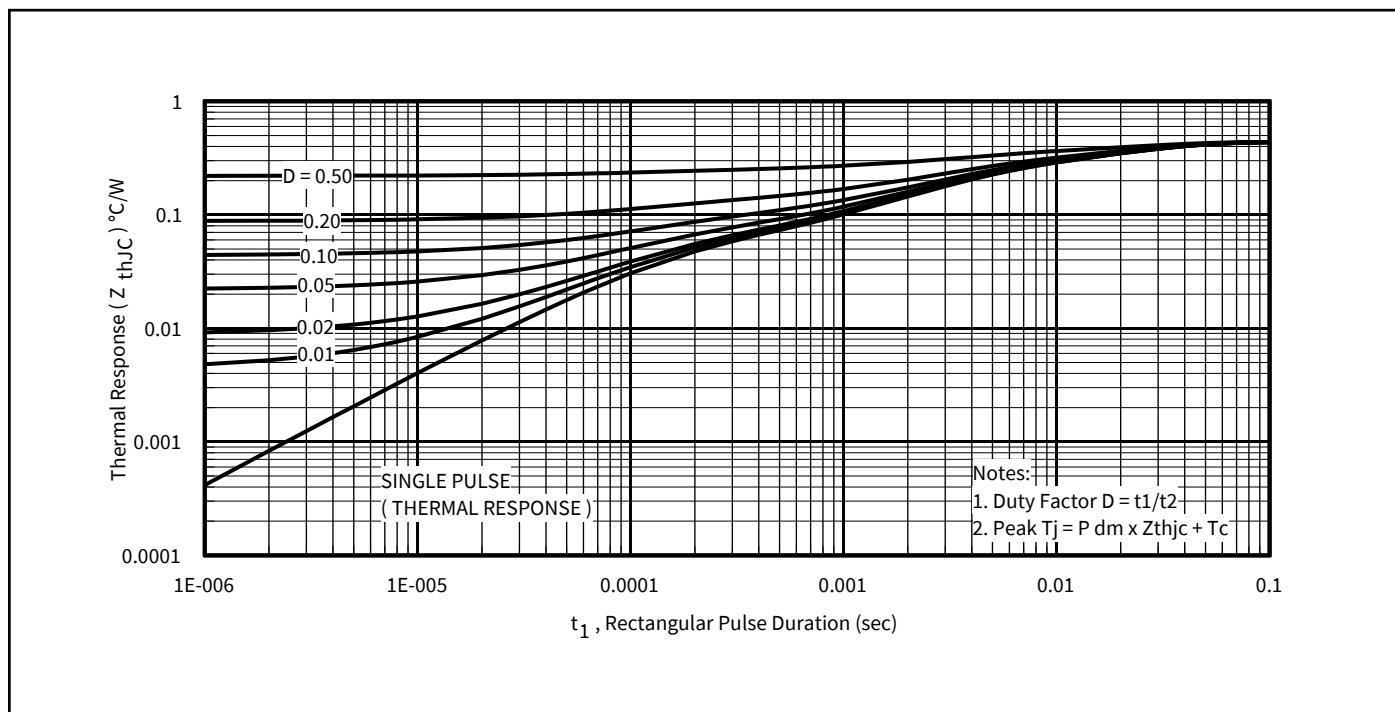


Figure 11 Drain-to-Source Breakdown Voltage

Figure 12 Typical Coss Stored Energy

**Figure 13** Typical On-Resistance vs. Drain Current**Figure 14** Threshold Voltage vs. Temperature**Figure 15** Maximum Effective Transient Thermal Impedance, Junction-to-Case

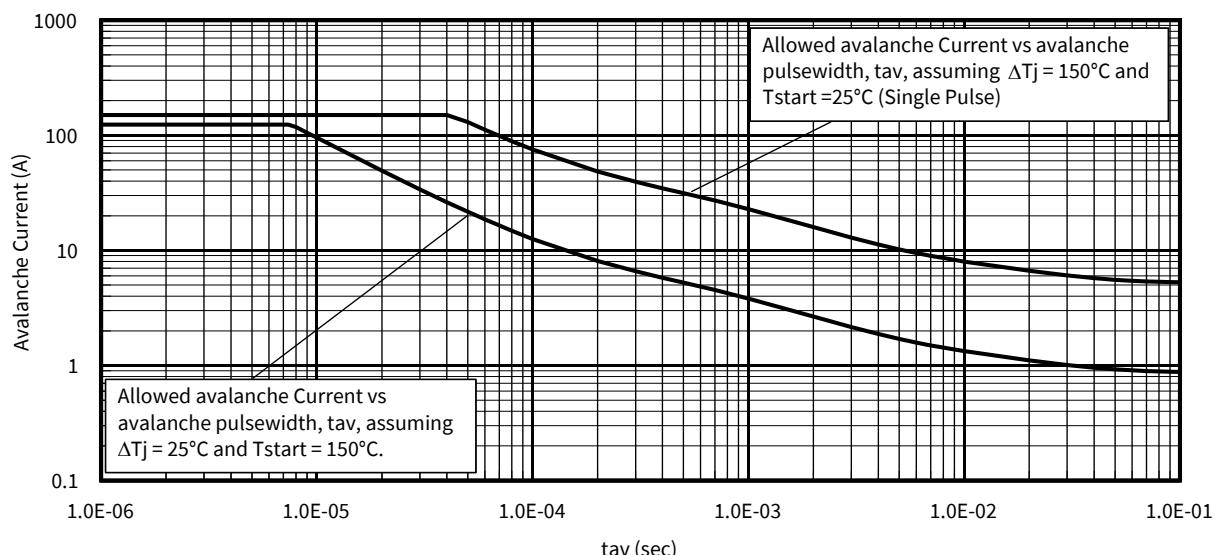
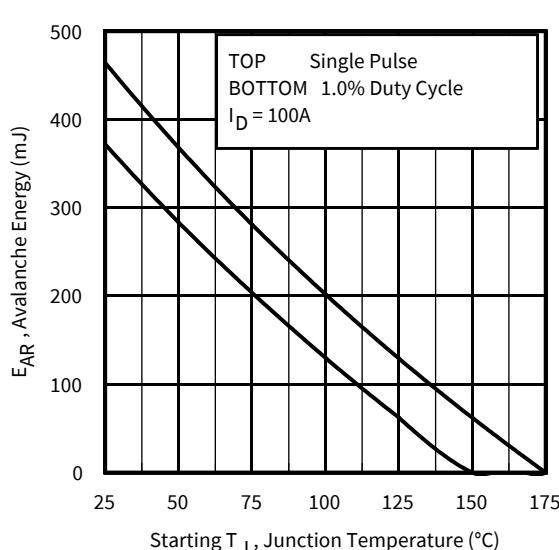


Figure 16 Avalanche Current vs. Pulse Width



Notes on Repetitive Avalanche Curves , Figures 16, 17: (For further info, see AN-1005 at www.infineon.com)

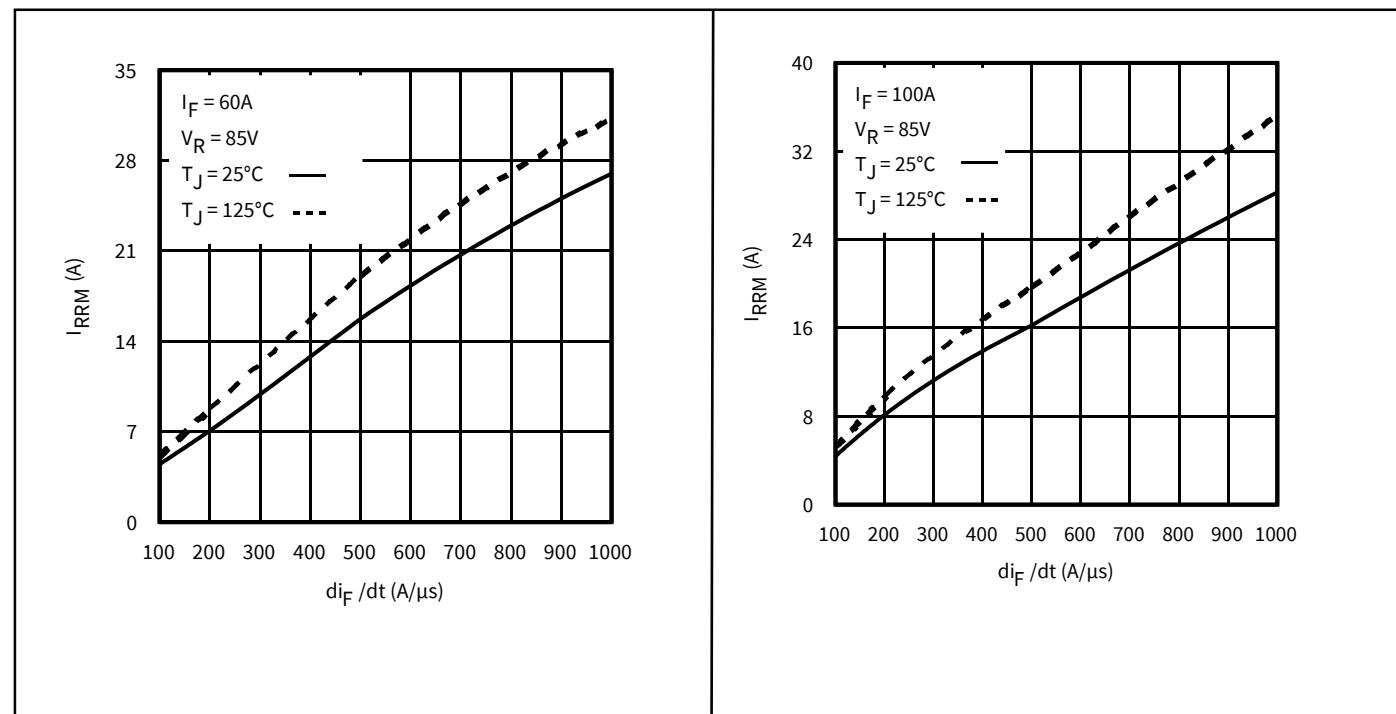
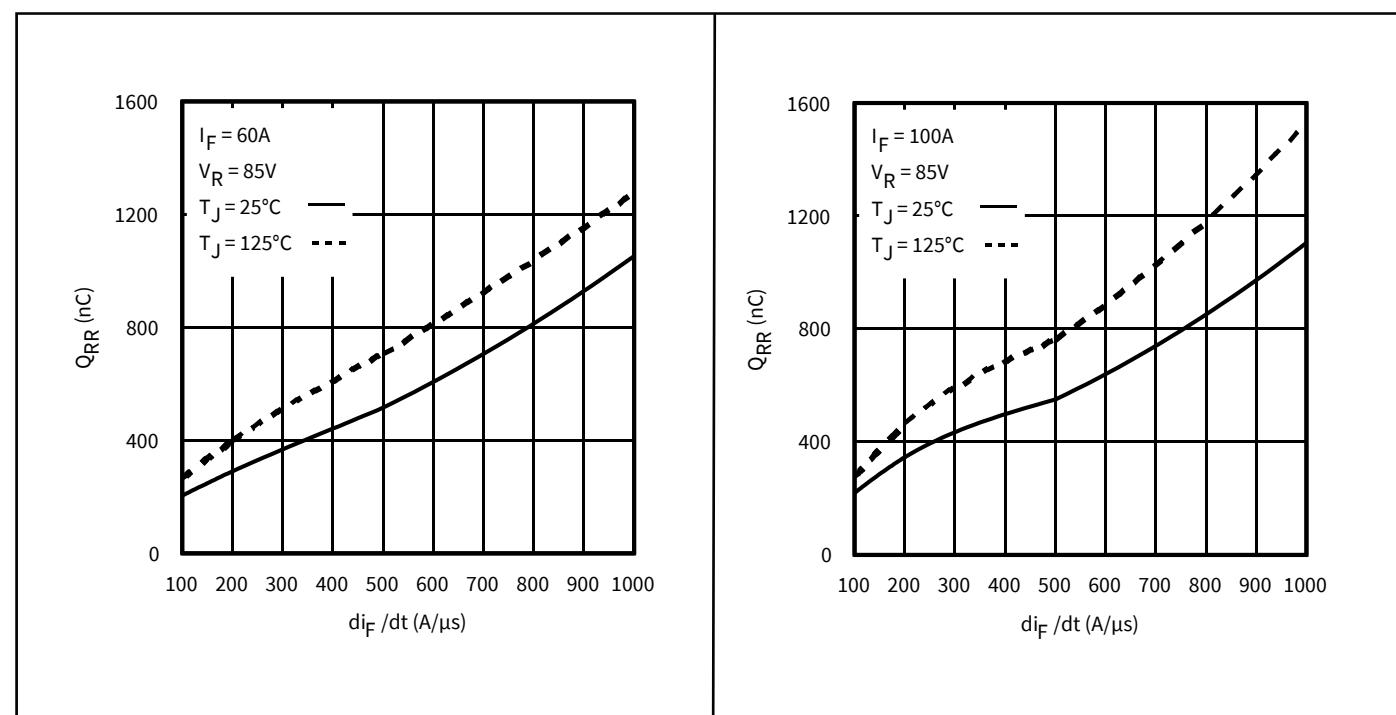
1. Avalanche failures assumption:
Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
 2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
 3. Equation below based on circuit and waveforms shown in Figures 23a, 23b.
 4. $P_{D(ave)}$ = Average power dissipation per single avalanche pulse.
 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
 6. I_{av} = Allowable avalanche current.
 7. DT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).
- t_{av} = Average time in avalanche.
 D = Duty cycle in avalanche = $t_{av} \cdot f$
 $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see Figures 14)

$$PD(ave) = 1/2 \cdot (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$$

$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$$

Figure 17 Maximum Avalanche Energy vs. Temperature

Figure 18 Typical Recovery Current vs. di/dt Figure 19 Typical Recovery Current vs. di/dt Figure 20 Typical Stored Charge vs. di/dt Figure 21 Typical Stored Charge vs. di/dt

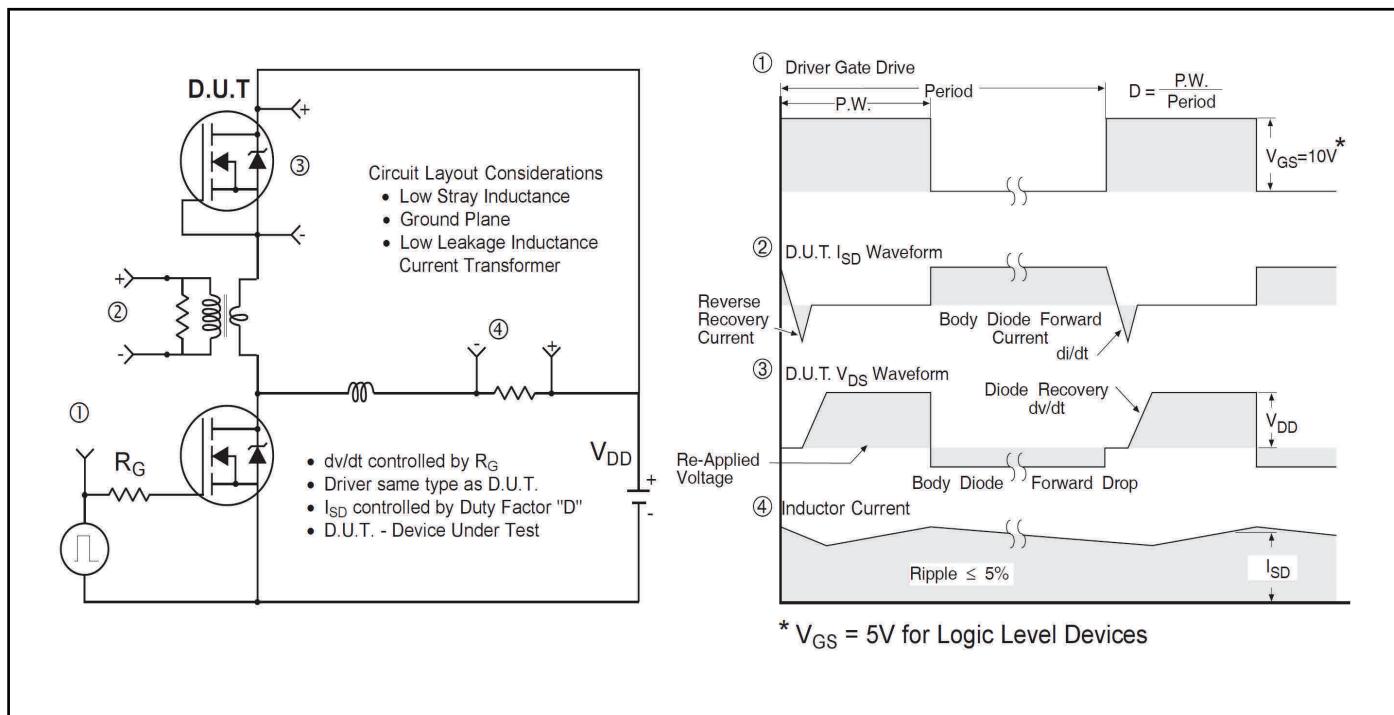
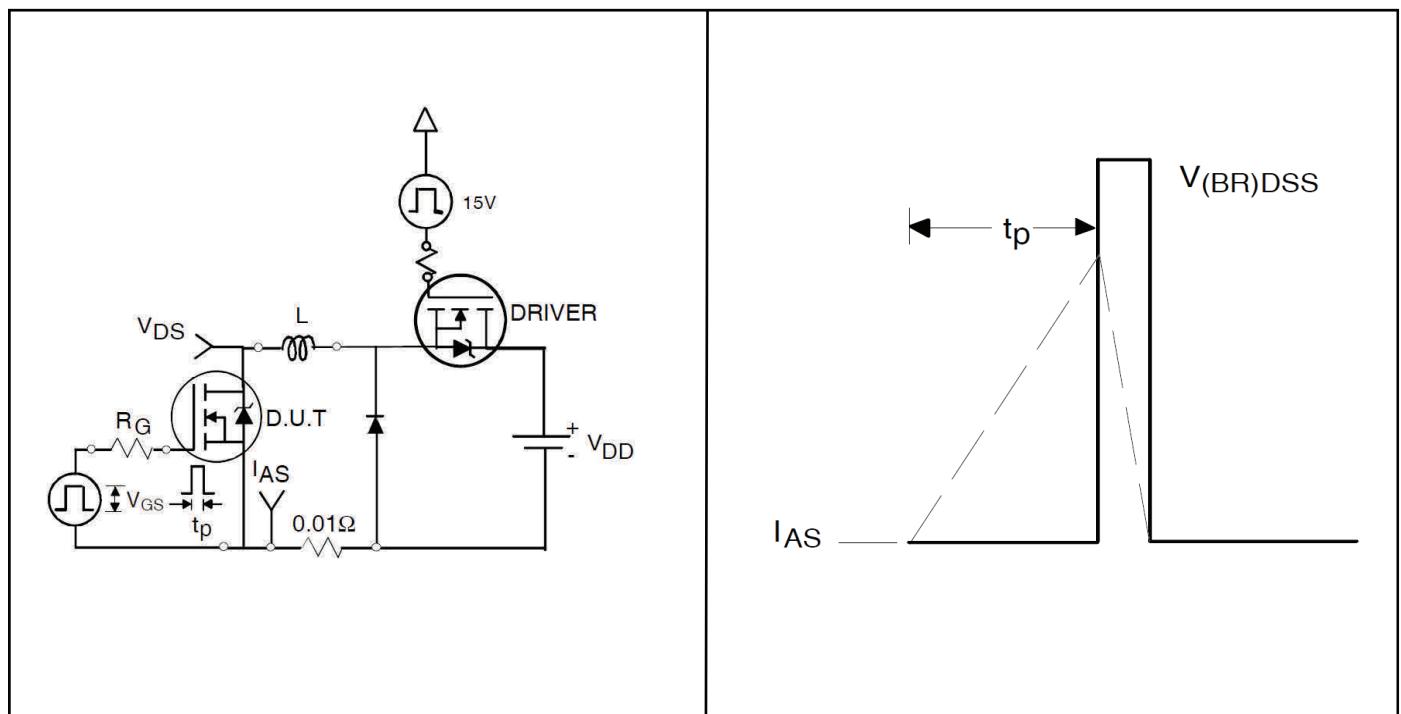
Figure 22 Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET™ Power MOSFETs

Figure 23a Unclamped Inductive Test Circuit

Figure 23b Unclamped Inductive Waveforms

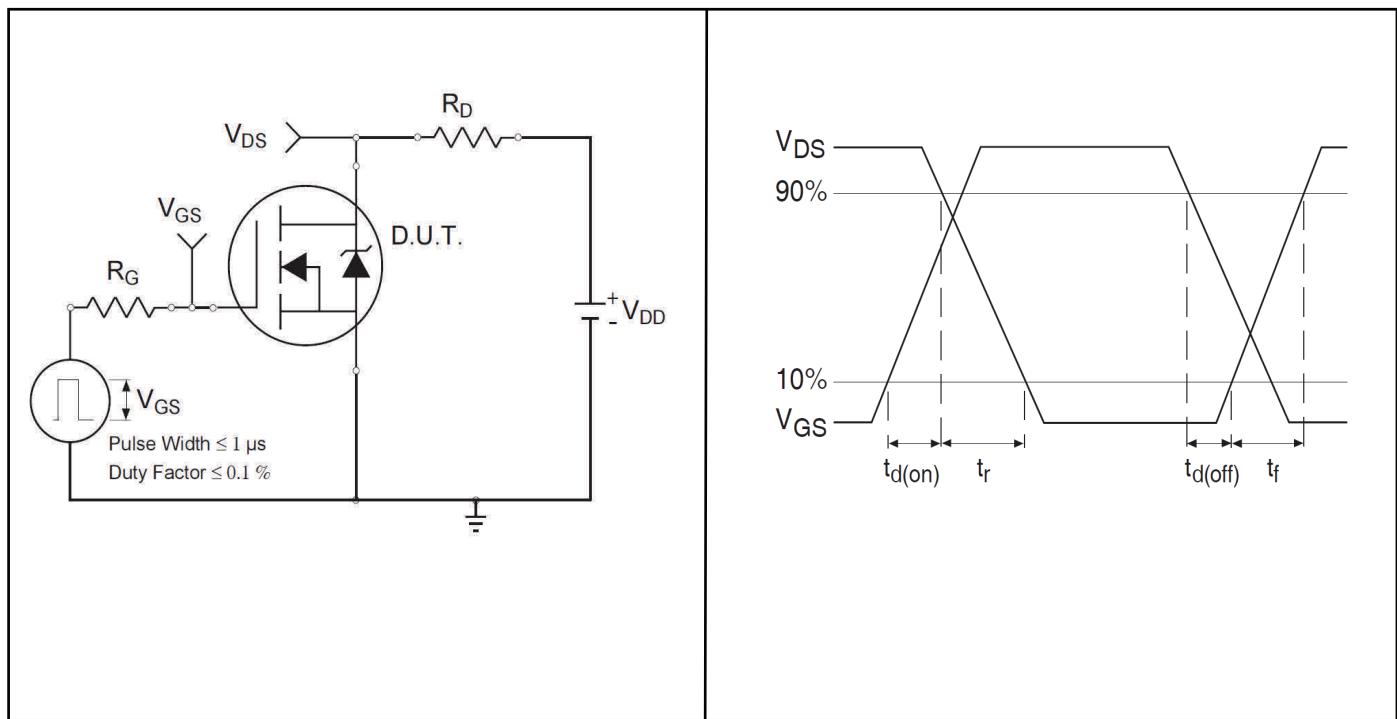


Figure 24a Switching Time Test Circuit

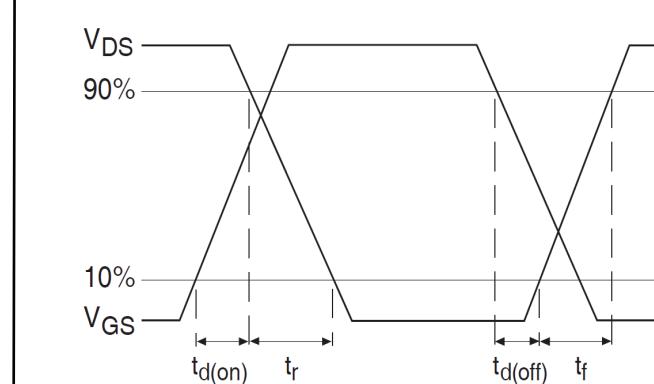


Figure 24b Switching Time Waveforms

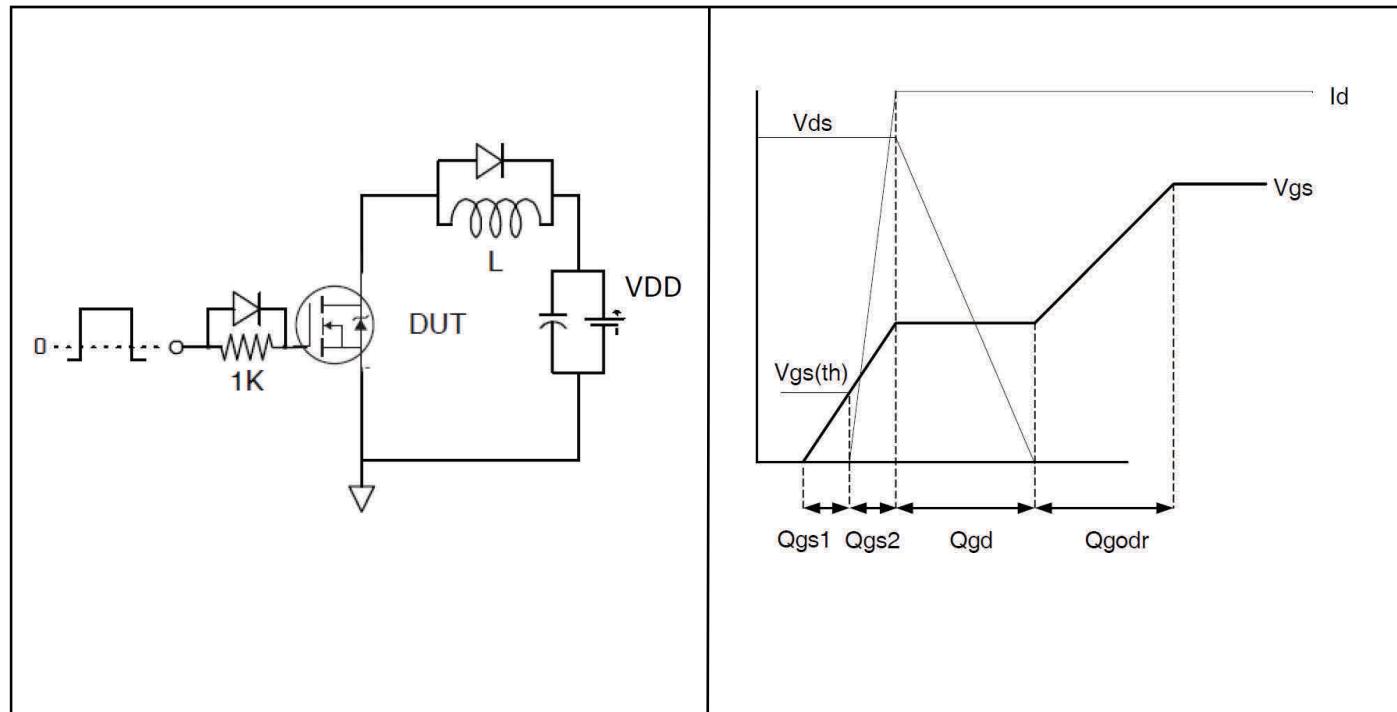


Figure 25a Gate Charge Test Circuit

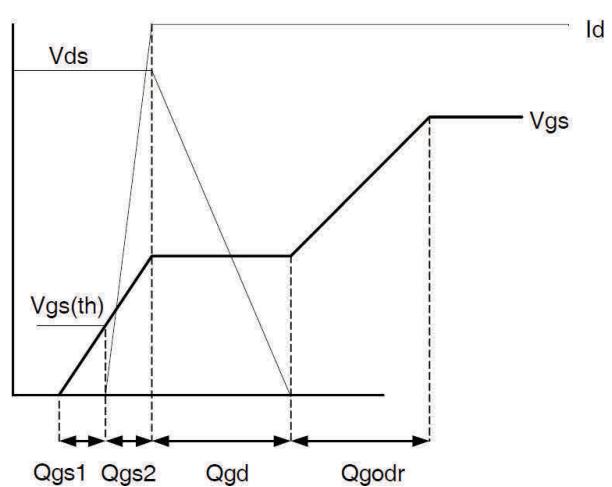
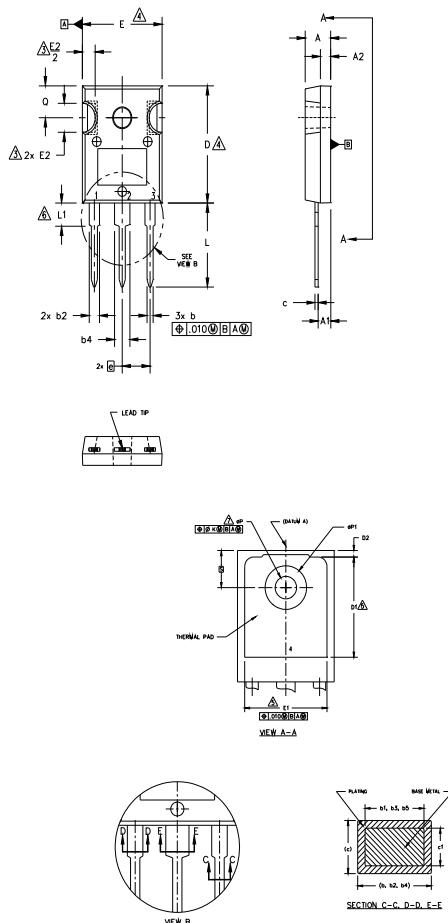


Figure 25b Gate Charge Waveform

5 Package Information

TO-247AC Package Outline (Dimensions are shown in millimeters (inches))



NOTES:

1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M 1994.
2. DIMENSIONS ARE SHOWN IN INCHES.
3. CONTOUR OF SLOT OPTIONAL.
4. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
5. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS D1 & E1.
6. LEAD FINISH UNCONTROLLED IN L1.
7. ØP TO HAVE A MAXIMUM DRAFT ANGLE OF 1.5° TO THE TOP OF THE PART WITH A MAXIMUM HOLE DIAMETER OF .154 INCH.
8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-247AC.

SYMBOL	DIMENSIONS				NOTES	
	INCHES		MILLIMETERS			
	MIN.	MAX.	MIN.	MAX.		
A	.183	.209	4.65	5.31		
A1	.087	.102	2.21	2.59		
A2	.059	.098	1.50	2.49		
b	.039	.055	0.99	1.40		
b1	.039	.053	0.99	1.35		
b2	.065	.094	1.65	2.39		
b3	.065	.092	1.65	2.34		
b4	.102	.135	2.59	3.43		
b5	.102	.133	2.59	3.38		
c	.015	.035	0.38	0.89		
c1	.015	.033	0.38	0.84		
D	.776	.815	19.71	20.70	4	
D1	.515	—	13.08	—	5	
D2	.020	.053	0.51	1.35		
E	.602	.625	15.29	15.87	4	
E1	.530	—	13.46	—		
E2	.178	.216	4.52	5.49		
e	.215 BSC		5.46 BSC			
Øk	.010		0.25			
L	.559	.634	14.20	16.10		
L1	.146	.169	3.71	4.29		
ØP	.140	.144	3.56	3.66		
ØP1	—	.291	—	7.39		
Q	.209	.224	5.31	5.69		
S	.217 BSC		5.51 BSC			

LEAD ASSIGNMENTS

HEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

IGBTs_CoPACK

- 1.- GATE
- 2.- COLLECTOR
- 3.- Emitter
- 4.- COLLECTOR

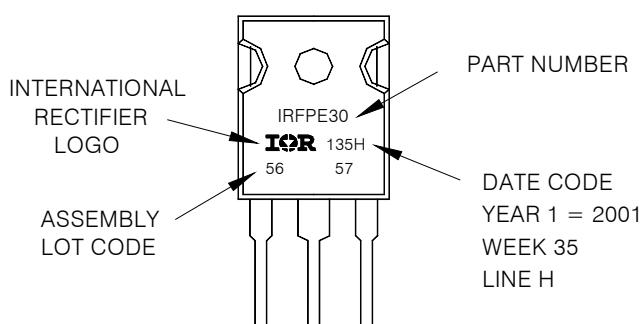
DIODES

- 1.- ANODE/OPEN
- 2.- CATHODE
- 3.- ANODE

TO-247AC Part Marking Information

EXAMPLE: THIS IS AN IRFPE30
WITH ASSEMBLY
LOT CODE 5657
ASSEMBLED ON WW 35, 2001
IN THE ASSEMBLY LINE "H"

Note: "P" in assembly line position
indicates "Lead-Free"



TO-247AC package is not recommended for Surface Mount Application.

6 Qualification Information

Qualification Information

Qualification Level	Industrial (per JEDEC JESD47F) †	
Moisture Sensitivity Level	TO-247AC	N/A
RoHS Compliant	Yes	

† Applicable version of JEDEC standard at the time of product release.

Revision History

Major changes since the last revision

Page or Reference	Revision	Date	Description of changes
All pages	2.0	2017-12-18	• First release data sheet.

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